

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

Sun, et al.

Serial No.: 10/611,805

Confirmation No.: Unknown

Filed:

June 30, 2003

For:

An Effective Method to Improve Surface Finish in Electrochemically Assisted

CMP

Group Art Unit: Unknown

Examiner:

Unknown

Commissioner for Patents

P.O. Box 1450 Alexandria, VA 22313-1450 CERTIFICATE OF MAILING 37 CFR 1.8

I hereby certify that this correspondence is being deposited on W/cc , 2003 with the United States Postal Service as First Class Mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450 Alexandria, VA 22313-1450.

Date

Signature

Dear Sir:

INFORMATION DISCLOSURE STATEMENT

The Applicants, and the Attorney who signs below on the basis of the information supplied by the inventor and the information in his file, submit herewith patents, publications, or other information of which they are aware, which may be material to the examination of this application and in respect of which there may be a duty to disclose in accordance with 37 CFR § 1.56.

While the information submitted in this Information Disclosure Statement may be material pursuant to 37 CFR § 1.56, it is not intended to constitute an admission that any patent, publication, or other information referred to therein is prior art for this invention unless specifically designated as such.

In accordance with 37 CFR § 1.97, this Information Disclosure Statement is not to be construed as a representation that a search has been made or that no other possibly material information as defined under 37 CFR § 1.56(a) exists.

The patents and/or publications submitted herewith are set forth on the attached Form PTO-1449.

If the sum of \$180.00 is due under 37 CFR § 1.17(p) pursuant to § 1.97, the Commissioner is hereby authorized to charge this fee, and any other fee necessary to make this submission timely, to the Deposit Account No. 20-0782/AMAT/6877/BKH.

Respectfully submitted,

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U.S. Departr	ment of	Commerce, Pate	Docke		Serial No.				
(PTO Form 1449 modified)						APPM/6877/CMP/ CMP/RKK		10/611,805	
LISTS OF P	ATENT	S AND PUBLICA	TIONS CITED	BY APPLICANT	Applic Sun, e		Confirmati UNKNOV		
(Use severa	l sheets	s if necessary)		8	Filing	Date	Group		
· · · · ·	E	xaminer UNKI	NOWN to !	101 1 3 3003 E	June 3	30, 2003	UNKNOV	۷N	
U.S. Patent	Docun	nents	NOWN P	40		1.00	1		
*Examiner Initial		Document Number	Issue Date	Applicant(s) Name	Class	Subclass	Filing Date I Appropriate	f	
	A28	6,066,030	05/23/2000	Uzoh	451	41	03/04/1999		
	A29	6,056,851	05/02/2000	Hsieh, et al.	156	345	08/14/1998	}	
	A30	6,024,630	02/15/2000	Shendon, et al.	451	41	06/09/1995	-	
	A31	6,020,264	02/01/2000	Lustig, et al.	438	692	01/31/1997	,	
	A32	6,017,265	01/25/2000	Cook et al.	451	41	01/13/1997	,	
	A33	6,004,880	12/21/1999	Liu, et al	438	692	02/20/1998		
	A34	6,001,008	12/14/1999	Fujimori, et al.	451	443	04/15/1999		
	A35	5,938,801	08/17/1999	Robinson	51	306	08/20/1998		
	A36	5,911,619	06/15/1999	Uzoh, et al	451	5	03/26/1997		
	A37	5,871,392	02/16/1999	Meikle et al.	451	56	06/13/1996		
	A38	5,846,882	12/08/1998	Birang	438	692	10/03/1996		
	A39	5,807,165	09/15/1998	Uzoh, et al	451	41	03/26/1997	,	
	A40	5,804,507	09/08/1998	Perlov, et al.	438	692	10/27/1995	5	
F reign Pa	tent Do	cuments		<u> </u>	<u> </u>		<u> </u>		
*Examiner		Document	Date	Country	Class	Subclass	Translation		
Initial		Number					YES	NO	
8	B12	WO 99/53119	10-21-1999	WIPO	C23C	18/18		X	
<u>n</u>	B13	WO 99/41434	08-19-1999	WIPO	C25D	5/02		Х	
C	B14	WO 98/49723	11/05/1998	WIPO	H01L	21/321		Х	
OTHER AR	T		•						
*Examiner Initial		Including Author, Pertinent Pages,							
	C5	International Search Report for PCT/US 02/11009 dated February 6, 2003.							
	C6								
	C7								
	C8								
Examiner	L				Date Co	nsidered			

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U.S. Depar	tment o	f Commerce, Pate	ent and Trad	emark Office	Docke	et No.	Sheet 4 of 4 Serial No	
(PTO Form			APPN CMP/I	1/6877/CMP/ RKK	10/611,805			
LISTS OF	PATEN	TS AND PUBLICA	ATIONS CIT	ED BY FAPPLICANT	Applio Sun, e		Confirmat	
(Use sever	al sheet	s if necessary)		NOV 1 3 2003 2	Filing	Date	Group	_
		Examiner UNK	MOMN &	C	June :	30, 2003	UNKNOWN	
U.S. Paten	t Docui	ments		TO THADEMARK				
*Examiner Initial		Document Number	Issue Date	Applicant(s) Name	Class	Subclass	Filing Date If Appropriate	
	A41	5,738,574	04/14/199	Tolles, et al.	451	288	10/27/1995	
	A42	5,624,300	04/29/199	7 Kishii, et al.	451	36	07/10/1996	
	A43	5,578,362	11/26/199	6 Reinhardt et al.	428	147	07/12/1994	
<u> </u>	A44	5,575,706	11/19/199	6 Tsai, et al	451	41	01/11/1996	
	A45	5,567,300	10/22/199	Datta, et al	205	652	09/02/1994	
-	A46	5,543,032	08/06/199	6 Datta, et al	205	670	06/02/1995	
	A47	5,136,817	08/11/199	2 Tabata, et al.	51	165.71	02/28/1991	
	A48	4,956,056	09/11/199	Zubatova, et al	204	129.43	03/20/1989	
	A49	4,954,141	09/04/199	Takiyama et al.	51	296	01/25/1989	1
	A50	4,839,993	06/20/198	Masuko, et al.	51	129	01/16/1987	
	A51	4,793,895	12/27/198	Kaanta, et al.	156	627	01/25/1988	
	A52	4,125,444	11/14/197	3 Inoue	204	129.43	12/13/1977	•
	A53	3,873,512	03/25/197	5 Latanision	204	129.46	04/30/1973	
	A54	3,162,588	12/22/196	4 Bell	204	141	04/17/1961	
	A55	2003/0114087	06/19/200	3 Duboust, et al.	451	41	06/04/2002	
	A56	2003/0116445	06/26/200	Sun, et al.	205	674	05/07/2002	
	A57	2002/0130049	09/19/200	Chen, et al.	205	640	01/03/2002	
	A58	2002/0119286	08/29/200	Chen, et al.	428	131	12/27/2001	
	A59	2003/0116446	06/26/200	3 Duboust, et al.	205	682	12/21/2001	
Foreign Pa	atent Do	ocuments	.1.		<u> </u>		 	
*Examiner Initial		Document Number	Date	Country	Class	Subclass	Transla YES	tion
o/	B15	0 455 455	04/29/199	1 EP	B23Q	15/007	<u> </u>	Х
OTHER AF	RT	1			I			L
*Examiner Initial		Including Author, Pertinent Pages, I						
	C9							
Examiner					Date Co	nsidered		

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U.S. Depart	ment of	Commerce, Pater	nt and Tradema	ark Office	Docket	No.	Serial No	
(PTO Form 1449 modified)						/6877/CMP/ RKK	10/611,805	
LISTS OF F	PATEN	TS AND PUBLICA	,	Applicant Sun, et al.		tion No VN		
(Use severa	al sheet	s if necessary)	Filing [Filing Date				
	I	Examiner UNKN	June 3	0, 2003	UNKNOV	۷N		
U.S. Patent	Docur	ments	7.	PADEMARK	-			
*Examiner Initial		Document Number	Issue Date	Applicant(s) Name	Class	Subclass	Filing Date I Appropriate	
	A13	6,297,159	10/02/2001	Paton	438	693	07/07/1999)
	A14	6,273,798	08/14/2001	Berman	451	72	07/27/1999)
	A15	6,248,222	06/19/2001	Wang	204	297.09	09/07/1999)
	A16	6,244,935	06/12/2001	Birang, et al.	451	41	02/04/1999)
	A17	6,238,271	05/29/2001	Cesna	451	41	04/30/1999)
<u> </u>	A18	6,234,870	05/22/2001	Uzoh, et al	451	8	08/24/1999)
	A19	6,210,257	04/03/2001	Carlson	451	56	05/29/1998	3
	A20	6,176,992	01/23/2001	Talieh	205	87	12/01/1998	3
	A21	6,171,467	01/09/2001	Weihs et al.	205	93	11/24/1998	3
	A22	6,159,079	12/12/2000	Zuniga, et al.	451	41	09/08/1998	3
	A23	6,156,124	12/05/2000	Tobin	118	719	10/06/1999)
· · ·	A24	6,153,043	11/28/2000	Edelstein, et al.	156	345	02-06-1998	3
	A25	6,116,998	09/12/2000	Damgaard, et al.	451	490	01/13/1998	3
	A26	6,103,096	08/15/2000	Datta, et al	205	686	11/12/1997	7
	A27	6,090,239	07/18/2000	Liu. et al	156	345	08/02/1999)
Foreign Pa	tent D	ocuments		1	. <u>.</u>			
*Examiner		Document	Date	Country	Class	Subclass	Translation	
Initial		Number					YES	NO
e/	B7	WO 01/49452	07-12-2001	WIPO	B24B	37/04		Х
2	B8	WO 00/59682	10-12-2000	WIPO	B24B	37/04		Х
	B9	WO 00/33356	06-08-2000	WIPO	H01L			Х
0	B10	WO 00/26443 v	05-11-2000	WIPO	C25D			X
<i>②</i>	B11	WO 00/03426	01-20-2000	WIPO	H01L	21/321		X
OTHER AF	RT							
*Examiner Initial		Including Author, 7 Pertinent Pages, E						
	C2	U.S. Patent Appl	ication 10/151	,538 filed on May	16, 2002.			
Examiner					Date Considered			

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U.S. Department of Commerce, Patent and Trademark Office						Docket No.		Serial No.		
(PTO Form 1449 modified)						APPM/6877/CMP/ CMP/RKK		10/611,805		
LISTS OF P	PATEN	TS AND PUBLICA		Applicant Sun, et al.		tion No VN				
(Use severa	l sheet	s if necessary)	Filing	Date	Group					
·		Examiner UNKI	NOWN 3	1 _C	June 3	30, 2003	UNKNOV	VN		
U.S. Patent	Docur	nents	ं१.७	BADEMARK						
*Examiner Initial		Document Number	Issue Date	Applicant(s) Name	Class	Subclass	Filing Date I Appropriate	f		
	A1	2002/0077037	06/20/2002	Tietz	451	41	07/20/2001			
	A2	2002/0070126	06/13/2002	Sato	205	640	09/19/2001			
	A3	2002/0008036	01/24/2002	Wang	205	118	04/18/2001			
	A4	2001/0042690	11/22/2001	Talieh	205	118	12/14/2000)		
· · · · · · · · · · · · · · · · · · ·	A5	2001/0040100	11/15/2001	Wang	205	220	04/16/2001			
	A6	2001/0036746	11/01/2001	Sato et al.	438	745	03/08/2001			
	A7	2001/0024878	09/27/2001	Nakamura	438	691	03/26/2001			
	A8	6,440,295	08/27/2002	Wang	205	640	02/04/2000			
	A9	6,395,152	05/28/2002	Wang	204	224 M	07/02/1999			
	A10	6,391,166	05/21/2002	Wang	204	224 R	01/15/1999)		
-	A11	6,386,956	05/14/2002	Sato, et al.	451	57	11/01/1999)		
	A12	6,381,169	04/30/2002	Bocian, et al.	365	151	07/01/1999)		
Foreign Pa	tent Do	ocuments			· · · · · · · · · · · · · · · · · · ·					
*Examiner		Document	Date	Country	Class	Subclass	Translation			
Initial		Number					YES	NO		
2	B1	EP 0 325 753	08-02-1989	EP	H01L	21/00		Х		
2/	B2	2001-77117	03-23-2001	JAPAN	H 01 L	21/3205		Х		
ر ا	В3	JP 11042554	02-16-1999	JAPAN	B24B	37/04		X		
2/	B4	WO 02/23616	03-21-2002	WIPO	H01L	21/44		Х		
0	B 5	WO 02/064314	08-22-2002	WIPO	B24B	37/04	_	X		
0/	В6	WO 01/88229	11-22-2001	WIPO	C25F	3/30		X		
OTHER AR	Т									
*Examiner Initial		Including Author, Pertinent Pages, E		-						
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Examiner					Date Co	Date Considered				

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